

Search Notes 	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10784877	FUKUDA ET AL.
	Examiner	Art Unit
	Kotini, Pavitra	3731

SEARCHED

Class	Subclass	Date	Examiner
606	75, 222, 223, 23, 28, 41, 43-45, 167, 170, 181, 184-189	2/8/07	PK
600	583	2/8/07	PK
411	494, 496-498, 490, 492	2/8/07	PK

SEARCH NOTES

Search Notes	Date	Examiner
class/subclass search	2/8/07	PK
keyword search within class/subclass	2/8/07	PK
Consulted with Primary Examiner Julian Woo for search and interpretation of claims, and allowability of claims	2/8/07, 2/12/07	PK
Consulted with examiner Victor Nguyen for allowability of claims	2/12/07	PK

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner